

**April 2014** 

# FDMS86550

# N-Channel PowerTrench<sup>®</sup> MOSFET 60 V, 155 A, 1.65 m $\Omega$

#### **Features**

- Max  $r_{DS(on)}$  = 1.65 m $\Omega$  at  $V_{GS}$  = 10 V,  $I_D$  = 32 A
- Max  $r_{DS(on)} = 2.2 \text{ m}\Omega$  at  $V_{GS} = 8 \text{ V}$ ,  $I_D = 27 \text{ A}$
- Advanced Package and Silicon combination for low r<sub>DS(on)</sub> and high efficiency
- MSL1 robust package design
- 100% UIL tested
- RoHS Compliant

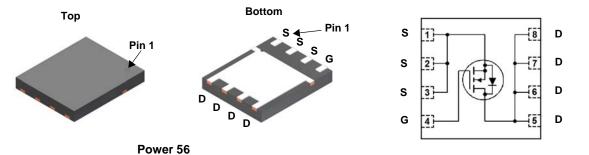


# **General Description**

This N-Channel MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench® process that has been especially tailored to minimize the on-state resistance and yet maintain superior switching performance.

# **Applications**

- Primary DC-DC MOSFET
- Secondary Synchronous Rectifier
- Load Switch



# MOSFET Maximum Ratings T<sub>A</sub> = 25 °C unless otherwise noted

Symbol	Parameter			Ratings	Units
$V_{DS}$	Drain to Source Voltage			60	V
$V_{GS}$	Gate to Source Voltage			±20	V
	Drain Current -Continuous	T <sub>C</sub> = 25 °C		155	
	-Continuous	T <sub>C</sub> = 100 °C		135	^
ID	-Continuous	T <sub>A</sub> = 25 °C	(Note 1a)	32	_ A
	-Pulsed		(Note 4)	320	
E <sub>AS</sub>	Single Pulse Avalanche Energy		(Note 3)	937	mJ
Б	Power Dissipation	T <sub>C</sub> = 25 °C		156	W
$P_D$	Power Dissipation	T <sub>A</sub> = 25 °C	(Note 1a)	2.7	VV
$T_J$ , $T_{STG}$	Operating and Storage Junction Temperature Range			-55 to +150	°C

## **Thermal Characteristics**

$R_{\theta JC}$	Thermal Resistance, Junction to Case	0.8	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1a)	45	C/VV

## **Package Marking and Ordering Information**

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMS86550	FDMS86550	Power 56	13 "	12 mm	3000 units

# **Electrical Characteristics** $T_J = 25$ °C unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Chara	cteristics					
$BV_{DSS}$	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	60			V
$\Delta BV_{DSS}$ $\Delta T_{J}$	Breakdown Voltage Temperature Coefficient	$I_D$ = 250 $\mu$ A, referenced to 25 °C		31		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 48 V, V <sub>GS</sub> = 0 V			1	μΑ
I <sub>GSS</sub>	Gate to Source Leakage Current	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$			±100	nA

#### **On Characteristics**

V <sub>GS(th)</sub>	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$	2.5	3.3	4.5	V
$\Delta V_{GS(th)} \over \Delta T_J$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D$ = 250 $\mu$ A, referenced to 25 °C		-12		mV/°C
		$V_{GS} = 10 \text{ V}, I_D = 32 \text{ A}$		1.4	1.65	
r <sub>DS(on)</sub>	r <sub>DS(on)</sub> Static Drain to Source On Resistance	$V_{GS} = 8 \text{ V}, I_{D} = 27 \text{ A}$		1.7	2.2	mΩ
	$V_{GS} = 10 \text{ V}, I_D = 32 \text{ A}, T_J = 125 ^{\circ}\text{C}$		2.2	2.6		
g <sub>FS</sub>	Forward Transconductance	$V_{DS} = 5 \text{ V}, I_{D} = 32 \text{ A}$		96		S

## **Dynamic Characteristics**

C <sub>iss</sub>	Input Capacitance	V 20.V V 0.V		8235	11530	pF
C <sub>oss</sub>	Output Capacitance	$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1  MHz		2140	3000	pF
C <sub>rss</sub>	Reverse Transfer Capacitance	1 - 1 1/11/12		70	120	pF
$R_g$	Gate Resistance		0.1	0.9	2.7	Ω

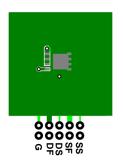
# **Switching Characteristics**

t <sub>d(on)</sub>	Turn-On Delay Time		43	69	ns
t <sub>r</sub>	Rise Time	V <sub>DD</sub> = 30 V, I <sub>D</sub> = 32 A,	27	43	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	$V_{GS} = 10 \text{ V}, R_{GEN} = 6 \Omega$	42	67	ns
t <sub>f</sub>	Fall Time		11	20	ns
Qg	Total Gate Charge	V <sub>GS</sub> = 0 V to 10 V	110	154	nC
Qg	Total Gate Charge	$V_{GS} = 0 \text{ V to 8 V}  V_{DD} = 30 \text{ V},$	90	126	nC
Q <sub>gs</sub>	Gate to Source Charge	I <sub>D</sub> = 32 A	40		nC
$Q_{gd}$	Gate to Drain "Miller" Charge		20		nC

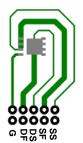
#### **Drain-Source Diode Characteristics**

Veb Source to Drain Diode Forward voltage	Source to Drain Diode Forward Voltage	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 2.1 A (Note 2)	0.7	1.2	V
	$V_{GS} = 0 \text{ V}, I_S = 32 \text{ A}$ (Note 2)	0.8	1.3	v	
t <sub>rr</sub>	Reverse Recovery Time	I <sub>E</sub> = 32 A. di/dt = 100 A/us	68	109	ns
Q <sub>rr</sub>	Reverse Recovery Charge	$I_F = 32 \text{ A}$ , $U/U = 100 \text{ A}/\mu\text{S}$	62	99	nC

<sup>1</sup> R<sub>0LA</sub> is determined with the device mounted on a 1 in<sup>2</sup> pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R<sub>0LC</sub> is guaranteed by design while R<sub>0CA</sub> is determined by the user's board design.



a. 45 °C/W when mounted on a 1 in<sup>2</sup> pad of 2 oz copper.



b. 115 °C/W when mounted on a minimum pad of 2 oz copper.

- 2. Pulse Test: Pulse Width < 300  $\mu$ s, Duty cycle < 2.0%.
- 3.  $E_{AS}$  of 937 mJ is based on starting  $T_{J}$  = 25 °C, L = 3 mH,  $I_{AS}$  = 25 A,  $V_{DD}$  = 60 V,  $V_{GS}$  = 10 V. 100% test at L = 0.1 mH,  $I_{AS}$  = 79 A.
- 4. Pulse Id refers to Figure.11 Forward Bias Safe Operation Area.

# Typical Characteristics T<sub>J</sub> = 25 °C unless otherwise noted

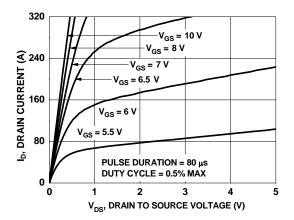


Figure 1. On-Region Characteristics

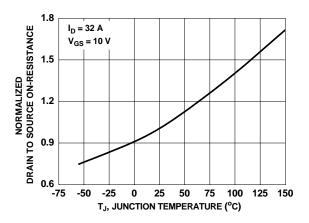


Figure 3. Normalized On-Resistance vs Junction Temperature

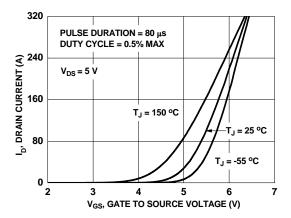


Figure 5. Transfer Characteristics

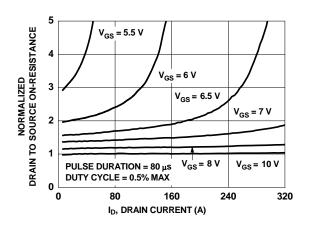


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

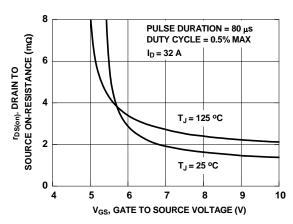


Figure 4. On-Resistance vs Gate to Source Voltage

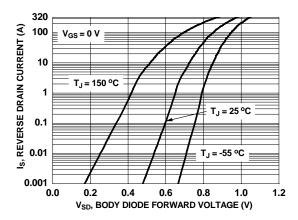


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

# **Typical Characteristics** $T_J = 25$ °C unless otherwise noted

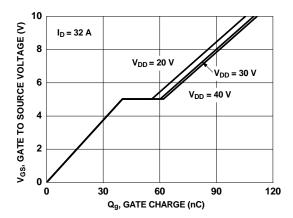


Figure 7. Gate Charge Characteristics

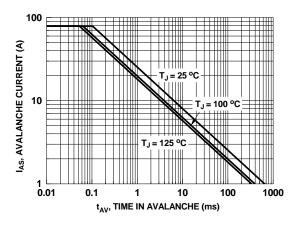


Figure 9. Unclamped Inductive Switching Capability

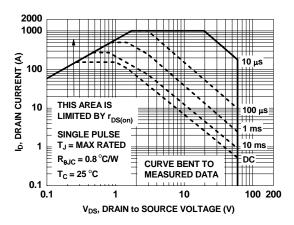


Figure 11. Forward Bias Safe Operating Area

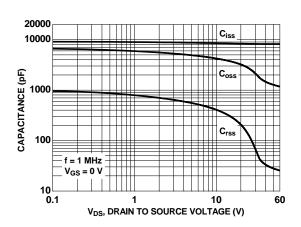


Figure 8. Capacitance vs Drain to Source Voltage

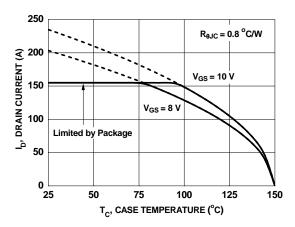


Figure 10. Maximum Continuous Drain Current vs Case Temperature

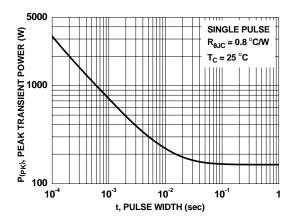


Figure 12. Single Pulse Maximum Power Dissipation

# Typical Characteristics T<sub>J</sub> = 25 °C unless otherwise noted

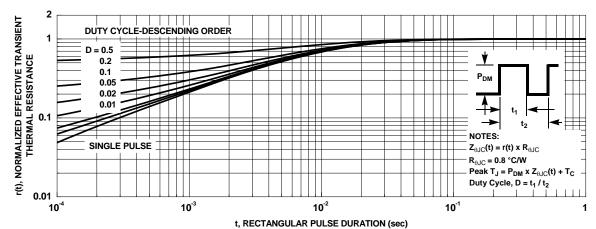
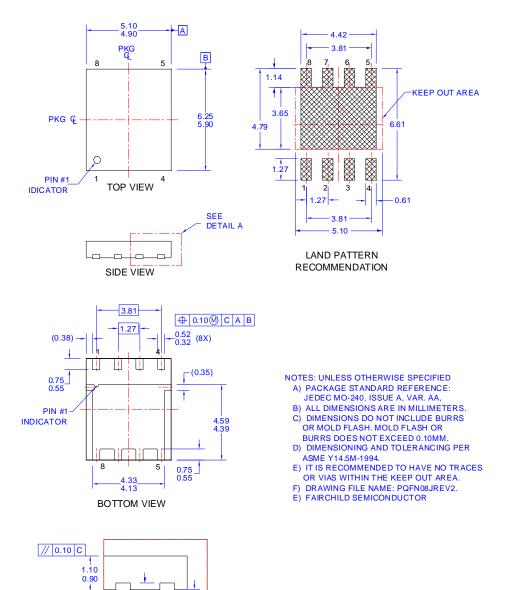


Figure 13. Transient Thermal Response Curve

# **Dimensional Outline and Pad Layout**



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SEATING

**PLANE** 

0.05

0.00

0.25

DETAIL A SCALE: 2:1

Always visit Fairchild Semiconductor's online packaging area for the most recent package drawings: http://www.fairchildsemi.com/package/packageDetails.html?id=PN\_PQDAM-008

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